

Application/Control No.	Applicant(s)/Patent under Reexamination
10/032,414	BRADD ET AL.
Examiner	Art Unit
John L. Shew	2664

	SEARCHED				
Class	Subclass	Date	Examiner		
370	338,351	2/24/2006	JS		
	352				
370	353,382	2/27/2006	JS		
	383,389				
	395.52				
	395.54				
	400,401				
	409				
	465,474				
709	225,227	2/28/2006	JS		
	228,229				
	238,245				
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

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